

Notice of References Cited	Application/Control No. 10/806,674	Applicant(s)/Patent Under Reexamination CHEN ET AL.	
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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2003/0125864	07-2003	Banno et al.	701/84
*	B	US-6,374,172	04-2002	Yamaguchi et al.	701/90
*	C	US-6,456,920	09-2002	Nishio et al.	701/70
*	D	US-6,658,342	12-2003	Hac, Aleksander B.	701/70
*	E	US-6,662,898	12-2003	Mattson et al.	180/446
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
*	N	JP 10181552 A	07-1998	Japan	IZUMI et al.	B60T 08/24
*	O	JP 2001004650 A	01-2001	Japan	YAMAGUCHI et al.	G01P 15/00
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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